

Notice of References Cited

Application/Control No.

10/824,434

Applicant(s)/Patent Under
Reexamination
YOON ET AL.

Examiner

ALVIN H. TAN

Art Unit

2173

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,941,356	09-2005	Meyerson, Matthew Scott	709/220
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NON-PATENT DOCUMENTS

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